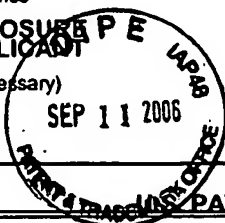


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ATTY. DOCKET NO.

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SERIAL NO.

10/540,401

APPLICANT

Akihiko NISHIO, et al.

FILING DATE

February 6, 2003

GROUP 2617

2001

Examiner: M.B. Khan

U.S. PATENT DOCUMENTS

EXAMINER INITIAL	DOCUMENT NUMBER	DATE	NAME	CLASS	SUBCLASS	FILING DATE IF APPROPRIATE
/M.K./	5 7 2 6 9 7 8	03/1998	Frodigh et al.			

FOREIGN PATENT DOCUMENTS

DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUBCLASS	TRANSLATION
					YES NO
9 7 0 1 2 5 6	01/1997	WO			

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/M.K./

Japanese Office Action dated July 27, 2006 with English translation.

EXAMINER

/Mehmood Khan/

DATE CONSIDERED

09/14/2007

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Akihiko NISHIO, et al.

FILING DATE

June 23, 2005

GROUP

Unassigned

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/M.K./	5 7 2 6 9 7 8	03/1998	Frodigh et al.			

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/M.K./	1 1 2 1 5 0 9 5	08/1999	JP			YES NO
	1 1 5 0 8 4 1 7	07/1999	JP			
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EXAMINER

/Mehmood Khan/

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